Hydrochloric Acid VLSI





Material No.: 5367-03 Batch No.: 0000204115 Manufactured Date: 2018/05/31 Retest Date: 2023/05/30 Revision No: 1

Certificate of Analysis

| Test | Specification | Result |
|-------------------------------------|---------------|---------|
| Assay (as HCl) (by acid-base titrn) | 37.0 - 38.0 % | 37.8 |
| Color (APHA) | <= 10 | 5 |
| Residue after Ignition | <= 3 ppm | < 1 |
| Extractable Organic Substances | <= 3 ppm | 1 |
| Bromide (Br) | <= 0.005 % | < 0.005 |
| Free Halogen (as Cl2) | Passes Test | РТ |
| Ammonium (NH4) | <= 1 ppm | < 1 |
| Phosphate (PO4) | <= 0.05 ppm | < 0.03 |
| Sulfate (SO4) | <= 0.3 ppm | < 0.3 |
| Sulfite (SO₃) | <= 0.8 ppm | 0.4 |
| Trace Impurities – Aluminum (Al) | <= 100.0 ppb | < 0.2 |
| Arsenic and Antimony (as As) | <= 5 ppb | < 3 |
| Trace Impurities – Barium (Ba) | <= 20.0 ppb | < 0.2 |
| Trace Impurities – Beryllium (Be) | <= 10.0 ppb | < 0.2 |
| Trace Impurities – Bismuth (Bi) | <= 20.0 ppb | < 1.0 |
| Trace Impurities – Boron (B) | <= 20.0 ppb | 1.8 |
| Trace Impurities – Cadmium (Cd) | <= 5.0 ppb | < 0.3 |
| Trace Impurities – Calcium (Ca) | <= 100.0 ppb | 17.7 |
| Trace Impurities – Chromium (Cr) | <= 50.0 ppb | < 1.0 |
| Trace Impurities – Cobalt (Co) | <= 5.0 ppb | < 0.3 |
| Frace Impurities – Copper (Cu) | <= 5.0 ppb | < 0.1 |
| Frace Impurities – Gallium (Ga) | <= 20.0 ppb | < 0.2 |
| Trace Impurities – Germanium (Ge) | <= 20.0 ppb | < 2.0 |
| Trace Impurities – Gold (Au) | <= 20.0 ppb | <1 |

For questions on this Certificate of Analysis please contact Technical Services at 855.282.6867 or +1.610.573.2600 Avantor Performance Materials, LLC.

3477 Corporate Parkway. Center Valley, PA 18034. U.S.A. Phone: 610.573.2600 . Fax: 610.573.2610

| Test | Specification | Result |
|-------------------------------------|---------------|--------|
| Heavy Metals (as Pb) | <= 100 ppb | < 50 |
| Frace Impurities – Iron (Fe) | <= 50.0 ppb | < 0.4 |
| Frace Impurities – Lead (Pb) | <= 25.0 ppb | < 0.5 |
| Frace Impurities – Lithium (Li) | <= 50.0 ppb | < 0.2 |
| Frace Impurities – Magnesium (Mg) | <= 50.0 ppb | 0.2 |
| Frace Impurities – Manganese (Mn) | <= 5.0 ppb | < 0.4 |
| Frace Impurities – Molybdenum (Mo) | <= 10.0 ppb | < 3.0 |
| Frace Impurities – Nickel (Ni) | <= 10.0 ppb | < 0.3 |
| Frace Impurities – Niobium (Nb) | <= 10.0 ppb | < 0.2 |
| Frace Impurities – Potassium (K) | <= 100.0 ppb | < 2.0 |
| Frace Impurities – Silicon (Si) | <= 100.0 ppb | 1.1 |
| Frace Impurities – Silver (Ag) | <= 20.0 ppb | < 0.3 |
| Frace Impurities – Sodium (Na) | <= 100.0 ppb | 0.5 |
| Frace Impurities – Strontium (Sr) | <= 20.0 ppb | < 0.2 |
| Frace Impurities – Tantalum (Ta) | <= 10.0 ppb | < 0.9 |
| Frace Impurities – Thallium (Tl) | <= 20.0 ppb | < 2.0 |
| Frace Impurities – Tin (Sn) | <= 50.0 ppb | <1 |
| Frace Impurities – Titanium (Ti) | <= 10.0 ppb | < 0.2 |
| Frace Impurities – Vanadium (V) | <= 10.0 ppb | < 0.2 |
| Frace Impurities – Zinc (Zn) | <= 50.0 ppb | < 1.0 |
| Frace Impurities – Zirconium (Zr) | <= 10.0 ppb | < 0.1 |
| Particle Count - 0.5 µm and greater | <= 50 par/ml | 10 |
| Particle Count - 1.0 µm and greater | <= 10 par/ml | 3 |

For Microelectronic Use

Reported value is the average of all samples counted for this lot number, with no individual sample value exceeding the specification.

Country of Origin: US Packaging Site: Phillipsburg Mfg Ctr & DC



Phillipsburg, NJ 9001:2015, FSSC 22000 Paris, KY 9001:2008 Mexico City, Mexico 9001:2008 Gliwice, Poland 9001:2008 Selangor, Malaysia 9001:2008 Dehradun, India 9001:2015, 14001:2015, 13485:2016 Mumbai, India 9001:2015 Panoli, India 9001:2015

James Techie

Jamie Ethier Vice President Global Quality

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